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Team Nexperia



# PBSS4580PA

80 V, 5.6 A NPN low V<sub>CEsat</sub> (BISS) transistor
Rev. 01 — 15 April 2010

Product data sheet

### **Product profile**

### 1.1 General description

NPN low V<sub>CEsat</sub> Breakthrough In Small Signal (BISS) transistor, encapsulated in an ultra thin SOT1061 leadless small Surface-Mounted Device (SMD) plastic package with medium power capability.

PNP complement: PBSS5580PA.

#### 1.2 Features and benefits

- Low collector-emitter saturation voltage V<sub>CEsat</sub>
- High collector current capability I<sub>C</sub> and I<sub>CM</sub>
- Smaller required Printed-Circuit Board (PCB) area than for conventional transistors
- Exposed heat sink for excellent thermal and electrical conductivity
- Leadless small SMD plastic package with medium power capability

### 1.3 Applications

- Loadswitch
- Battery-driven devices
- Power management
- Charging circuits
- Power switches (e.g. motors, fans)

### 1.4 Quick reference data

Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
$V_{CEO}$	collector-emitter voltage	open base	-	-	80	V
$I_{C}$	collector current		-	-	5.6	Α
I <sub>CM</sub>	peak collector current	single pulse; $t_p \le 1 \text{ ms}$	-	-	7	Α
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_C = 5.6 \text{ A};$ $I_B = 280 \text{ mA}$	<u>[1]</u> -	40	57	mΩ

<sup>[1]</sup> Pulse test:  $t_p \le 300 \ \mu s; \ \delta \le 0.02.$ 



## 2. Pinning information

Table 2. Pinning

Pin	Description	Simplified outline	Graphic symbol
1	base		_
2	emitter	3	3
3	collector	1 2 Transparent top view	12 sym021

## 3. Ordering information

Table 3. Ordering information

Type number	Package	Package		
	Name	Description	Version	
PBSS4580PA	HUSON3	plastic thermal enhanced ultra thin small outline package; no leads; three terminals; body $2 \times 2 \times 0.65$ mm	SOT1061	

## 4. Marking

Table 4. Marking codes

Type number	Marking code
PBSS4580PA	AD

## 5. Limiting values

Table 5. Limiting values

In accordance with the Absolute Maximum Rating System (IEC 60134).

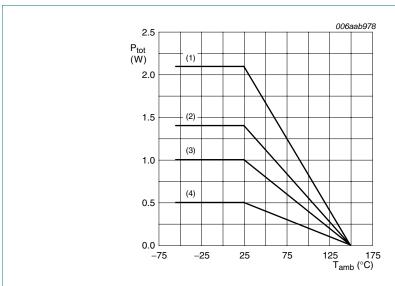
Symbol	Parameter	Conditions	Min	Max	Unit
$V_{CBO}$	collector-base voltage	open emitter	-	80	V
$V_{CEO}$	collector-emitter voltage	open base	-	80	V
$V_{EBO}$	emitter-base voltage	open collector	-	6	V
I <sub>C</sub>	collector current		-	5.6	Α
I <sub>CM</sub>	peak collector current	$\begin{array}{l} \text{single pulse;} \\ t_p \leq 1 \text{ ms} \end{array}$	-	7	Α
I <sub>B</sub>	base current		-	600	mA
P <sub>tot</sub>	total power dissipation	$T_{amb} \le 25  ^{\circ}C$	[1] -	500	mW
			[2] _	1	W
			[3]	1.4	W
			[4] -	2.1	W

Table 5. Limiting values ... continued

In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
Tj	junction temperature		-	150	°C
T <sub>amb</sub>	ambient temperature		-55	+150	°C
T <sub>stg</sub>	storage temperature		-65	+150	°C

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- [3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.
- [4] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.



- (1) Ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint
- (2) FR4 PCB, mounting pad for collector 6 cm<sup>2</sup>
- (3) FR4 PCB, mounting pad for collector 1 cm<sup>2</sup>
- (4) FR4 PCB, standard footprint

Fig 1. Power derating curves

### 6. Thermal characteristics

Table 6. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
R <sub>th(j-a)</sub> thermal resistance from junction to ambient		in free air	<u>[1]</u> _	-	250	K/W
		[2]	-	125	K/W	
		[3]	-	90	K/W	
			[4]	-	60	K/W

- [1] Device mounted on an FR4 PCB, single-sided copper, tin-plated and standard footprint.
- [2] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 1 cm<sup>2</sup>.
- 3] Device mounted on an FR4 PCB, single-sided copper, tin-plated, mounting pad for collector 6 cm<sup>2</sup>.
- [4] Device mounted on a ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint.

PBSS4580PA\_1

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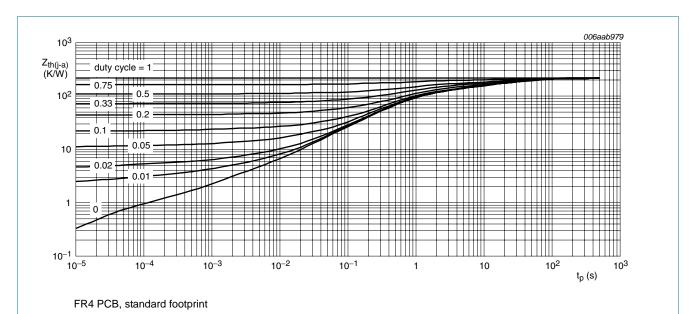
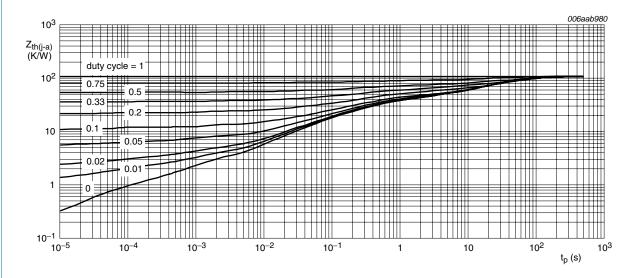


Fig 2. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



FR4 PCB, mounting pad for collector 1 cm<sup>2</sup>

Fig 3. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

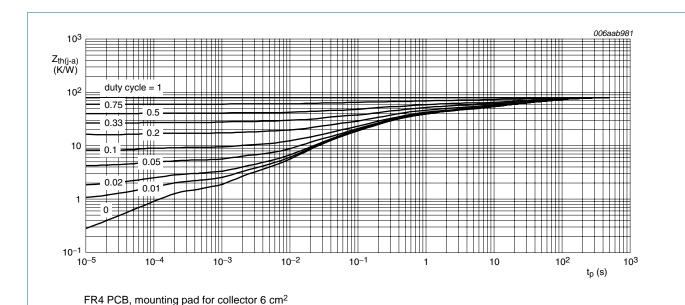
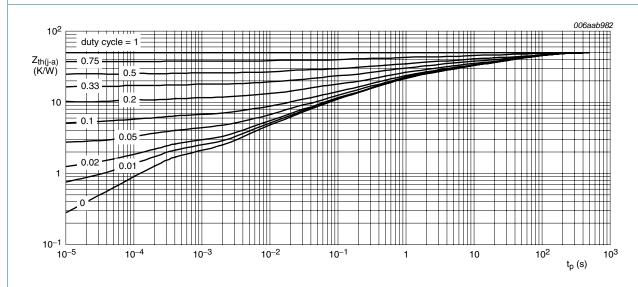


Fig 4. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values



Ceramic PCB, Al<sub>2</sub>O<sub>3</sub>, standard footprint

Fig 5. Transient thermal impedance from junction to ambient as a function of pulse duration; typical values

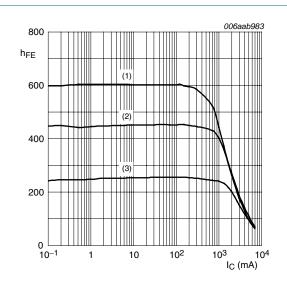
## 7. Characteristics

**Table 7. Characteristics** 

 $T_{amb} = 25$  °C unless otherwise specified.

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I <sub>CBO</sub>	collector-base	$V_{CB} = 64 \text{ V}; I_E = 0 \text{ A}$	-	-	100	nA
	cut-off current	$V_{CB} = 64 \text{ V}; I_E = 0 \text{ A};$ $T_j = 150 \text{ °C}$	-	-	50	μА
I <sub>CES</sub>	collector-emitter cut-off current	$V_{CE} = 64 \text{ V}; V_{BE} = 0 \text{ V}$	-	-	100	nA
I <sub>EBO</sub>	emitter-base cut-off current	$V_{EB} = 5 \text{ V}; I_{C} = 0 \text{ A}$	-	-	100	nA
h <sub>FE</sub>	DC current gain	V <sub>CE</sub> = 2 V	[1]			
		$I_C = 0.5 A$	270	425	-	
		I <sub>C</sub> = 1 A	240	375	-	
		I <sub>C</sub> = 2 A	150	245	-	
	I <sub>C</sub> = 6 A	45	75	-		
V <sub>CEsat</sub>	collector-emitter	$I_C = 0.5 \text{ A}; I_B = 50 \text{ mA}$	<u>[1]</u> -	25	35	mV
	saturation voltage	$I_C = 1 A$ ; $I_B = 50 \text{ mA}$	[1] -	50	70	mV
		$I_C = 1 A$ ; $I_B = 10 mA$	<u>[1]</u> -	85	120	mV
		$I_C = 2 A$ ; $I_B = 20 mA$	<u>[1]</u> -	150	220	mV
		$I_C = 3 A$ ; $I_B = 30 mA$	<u>[1]</u> -	265	360	mV
		$I_C = 4 A$ ; $I_B = 400 \text{ mA}$	<u>[1]</u> -	155	210	mV
		$I_C = 5.6 \text{ A}; I_B = 280 \text{ mA}$	<u>[1]</u> -	230	320	mV
R <sub>CEsat</sub>	collector-emitter saturation resistance	$I_C = 5.6 \text{ A}; I_B = 280 \text{ mA}$	[1] -	40	57	mΩ
V <sub>BEsat</sub>	base-emitter	$I_C = 1 A; I_B = 10 mA$	<u>[1]</u> -	0.74	0.9	V
	saturation voltage	$I_C = 5.6 \text{ A}; I_B = 280 \text{ mA}$	<u>[1]</u> -	1	1.1	V
$V_{BEon}$	base-emitter turn-on voltage	$V_{CE} = 2 \text{ V}; I_{C} = 2 \text{ A}$	[1] -	0.76	0.9	V
t <sub>d</sub>	delay time	$V_{CC} = 9 \text{ V}; I_C = 2 \text{ A};$	-	21	-	ns
t <sub>r</sub>	rise time	$I_{Bon} = 0.1 \text{ A};$ $I_{Boff} = -0.1 \text{ A}$	-	162	-	ns
t <sub>on</sub>	turn-on time	- I <sub>Boff</sub> = −0.1 A	-	183	-	ns
t <sub>s</sub>	storage time		-	720	-	ns
t <sub>f</sub>	fall time		-	205	-	ns
t <sub>off</sub>	turn-off time		-	925	-	ns
f⊤	transition frequency	V <sub>CE</sub> = 10 V; I <sub>C</sub> = 100 mA; f = 100 MHz	95	155	-	MHz
C <sub>c</sub>	collector capacitance	$V_{CB} = 10 \text{ V}; I_E = i_e = 0 \text{ A};$ f = 1 MHz	-	20	25	pF

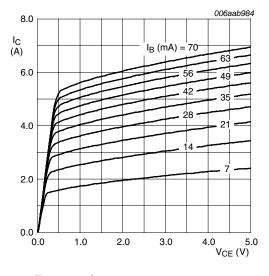
<sup>[1]</sup> Pulse test:  $t_p \le 300~\mu s;~\delta \le 0.02.$ 



$$V_{CE} = 2 V$$

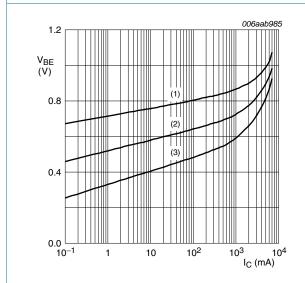
- (1) T<sub>amb</sub> = 100 °C
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = -55 \, ^{\circ}C$

Fig 6. DC current gain as a function of collector current; typical values



 $T_{amb} = 25 \, ^{\circ}C$ 

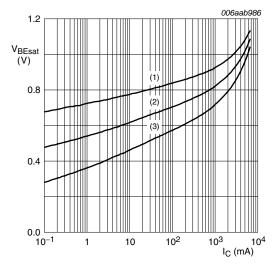
Fig 7. Collector current as a function of collector-emitter voltage; typical values





- (1)  $T_{amb} = -55 \,^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

Fig 8. Base-emitter voltage as a function of collector current; typical values

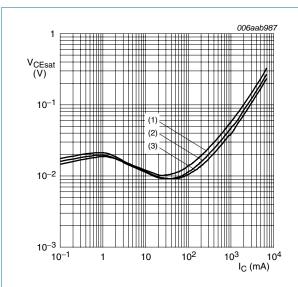


$$I_{\rm C}/I_{\rm B} = 20$$

- (1)  $T_{amb} = -55 \, ^{\circ}C$
- (2)  $T_{amb} = 25 \, ^{\circ}C$
- (3)  $T_{amb} = 100 \, ^{\circ}C$

Fig 9. Base-emitter saturation voltage as a function of collector current; typical values

80 V, 5.6 A NPN low  $V_{\text{CEsat}}$  (BISS) transistor



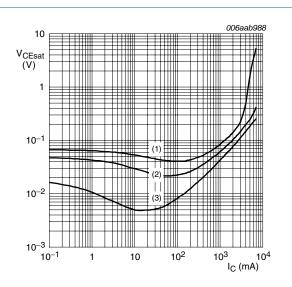
$$I_{\rm C}/I_{\rm B} = 20$$

(1) 
$$T_{amb} = 100 \, ^{\circ}C$$

(2) 
$$T_{amb} = 25 \, ^{\circ}C$$

(3) 
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 10. Collector-emitter saturation voltage as a function of collector current; typical values

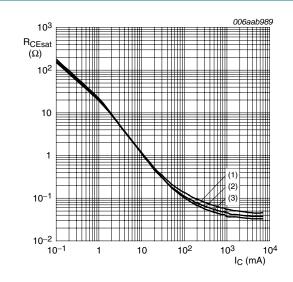


(1) 
$$I_C/I_B = 100$$

(2) 
$$I_C/I_B = 50$$

(3) 
$$I_C/I_B = 10$$

Fig 11. Collector-emitter saturation voltage as a function of collector current; typical values



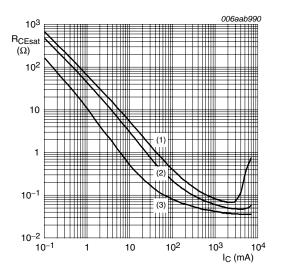
$$I_{\rm C}/I_{\rm B} = 20$$

(1) 
$$T_{amb} = 100 \, ^{\circ}C$$

(2) 
$$T_{amb} = 25 \, ^{\circ}C$$

(3) 
$$T_{amb} = -55 \, ^{\circ}C$$

Fig 12. Collector-emitter saturation resistance as a function of collector current; typical values



(1) 
$$I_C/I_B = 100$$

(2) 
$$I_C/I_B = 50$$

(3) 
$$I_C/I_B = 10$$

Fig 13. Collector-emitter saturation resistance as a function of collector current; typical values

## 8. Test information

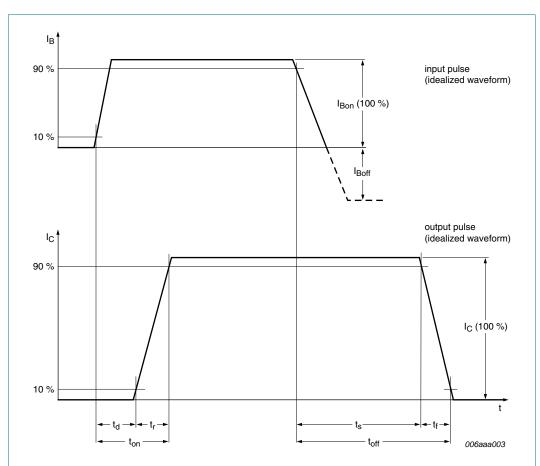


Fig 14. BISS transistor switching time definition

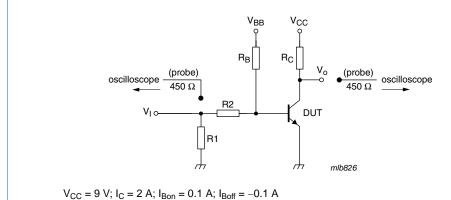
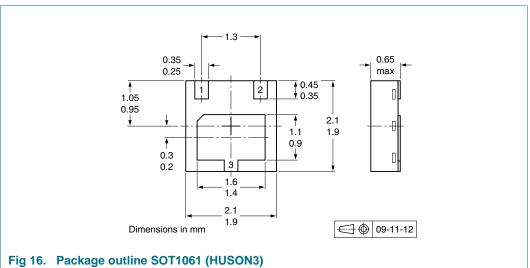


Fig 15. Test circuit for switching times

## Package outline



## 10. Packing information

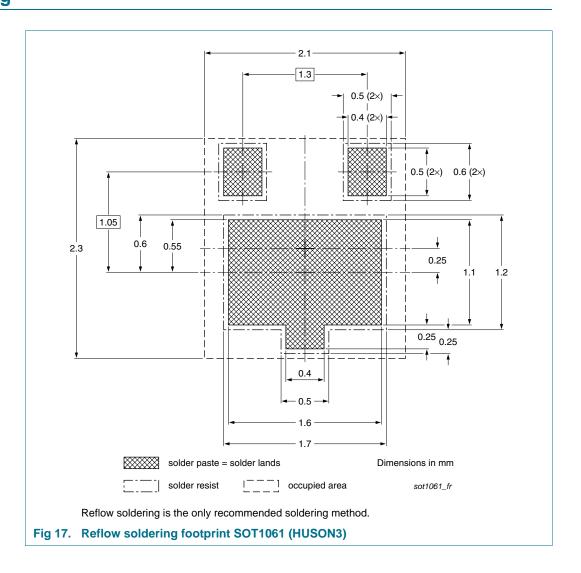
Table 8. **Packing methods** 

The indicated -xxx are the last three digits of the 12NC ordering code.[1]

Type number	Package	Description	Packing quantity
			3000
PBSS4580PA	SOT1061	4 mm pitch, 8 mm tape and reel	-115

<sup>[1]</sup> For further information and the availability of packing methods, see Section 14.

## 11. Soldering





# 12. Revision history

### Table 9. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PBSS4580PA_1	20100415	Product data sheet	-	-

### 13. Legal information

#### 13.1 Data sheet status

Document status[1][2]	Product status[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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- [2] The term 'short data sheet' is explained in section "Definitions"
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NXP Semiconductors PBSS4580PA

### 80 V, 5.6 A NPN low V<sub>CEsat</sub> (BISS) transistor

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# PBSS4580PA

## 80 V, 5.6 A NPN low V<sub>CEsat</sub> (BISS) transistor

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